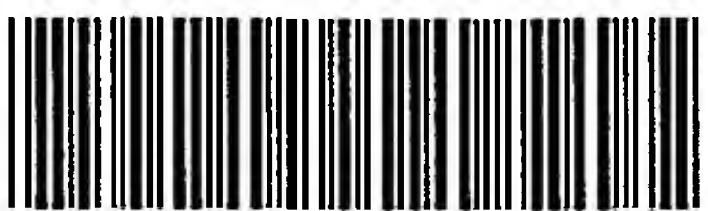


## **Search Notes**



**Application/Control No.**

10/614,676

**Examiner**

Ryan M. Stiglic

**Applicant(s)/Patent under  
Reexamination**

LIN ET AL.

## **Art Unit**

2112

**SEARCHED**

# **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**

## INTERFERENCE SEARCHED

<b>INTERFERENCE SEARCHED</b>			
Class	Subclass	Date	Examiner